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Dr. Ha-Jin Lee, Ph.D

Western Seoul Center, Korea Basic Science Institute
Republic of Korea



Dr. Ha-Jin Lee received the B.S degree (1995), M.S degree (1997) and Ph.D degree (2001) from Department of Chemistry at Seoul Women's University, in Korea. She worked as a JSPS postdoctoral fellow at Institute for Molecular Science (IMS), Okazaki in Japan (June 2002 – Jan. 2004), and as a postdoc at National Institute of Standards and Technology (NIST), Gaithersburg, MD in USA (Feb. 2004 – Aug. 2005). Since joining as a senior research scientist at the Korea Basic Science Institute (KBSI) in September of 2005, she has working as a principal research scientist at Western Seoul Center, KBSI. Her research interests mainly include material chemistry, structural analysis, and the comprehensive testing of newly discovered nanomaterials. Since 2008, she has been involving as an expert on nanotechnology standardization of International Electrotechnical Commission (IEC), and has been leading the international standardization technology for evaluating the electrical conductivity of carbon nanomaterials such as carbon nanotube and graphene.